

Notice of References Cited	Application/Control No. 10/511,908	Applicant(s)/Patent Under Reexamination IKEDA ET AL.	
	Examiner Karen Masih	Art Unit 2837	Page 1 of 1

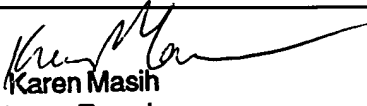
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0184251	10-2003	Oyama et al.	318/607
*	B	US-5,767,609	06-1998	Suganuma, Ryoichi	310/316.02
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	 Karen Masih Primary Examiner
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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